DW OR N PACKAGE

SDAS300 - MARCH 1995

- Bidirectional Bus Transceivers in High-Density 20-Pin Packages
- Choice of True or Inverting Logic
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (N) 300-mil DIPs

DEVICE	LOGIC
SN74ALS641A, SN74AS641	True
SN74ALS642A	Inverting

(TOP VIEW) DIR 20 ∏ Vcc Α1 19 OE 2 А2 П 3 18**∏** B1 А3 П 17 **∏** B2 4 А4 Г 5 16 П вз A5 [15 **∏** B4 14 | B5 A6 [А7 Г 8 13**∏** B6 A8 **∏** 9 12 🛮 B7 GND 10 11 B8

description

These octal bus transceivers are designed for asynchronous two-way communication between

data buses. These devices transmit data from the A bus to the B bus or from the B bus to the A bus, depending upon the level at the direction-control (DIR) input. The output-enable (\overline{OE}) input disables the device so that the buses are effectively isolated.

The -1 versions of the SN74ALS641A and SN74ALS642A are identical to the standard versions, except that the recommended maximum I_{OI} is increased to 48 mA in the -1 versions.

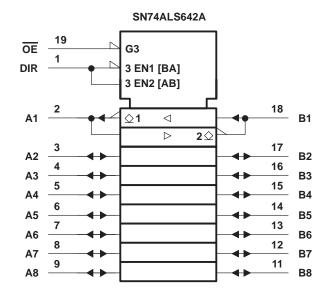
The SN74ALS641A, SN74ALS642A, and SN74AS641 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE

INP	UTS	OPERATION			
ŌE DIR		SN74ALS641A SN74AS641	SN74ALS642A		
L	L	B data to A bus	B data to A bus		
L	Н	A data to B bus	A data to B bus		
Н	Χ	Isolation	Isolation		

logic symbols†

SN74ALS641A, SN74AS641 19 OE G3 1 DIR 3 EN1 [BA] 3 EN2 [AB] 18 \triangleleft В1 \triangleright 2♀ 3 17 **A2 B2** 4 16 А3 **B3** 5 15 Α4 **B4** 6 14 Α5 **B5** 7 Α6 **B6** 12 8 **A7 B7** 9 11 **A8 B8**



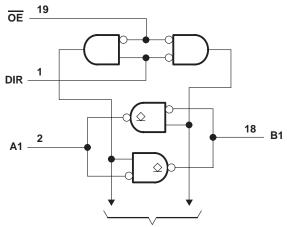
[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

TEXAS INSTRUMENTS

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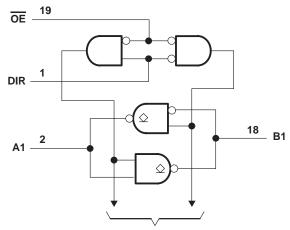
logic diagrams (positive logic)

SN74ALS641A, SN74AS641





SN74ALS642A



To Seven Other Transceivers

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}		
Input voltage, V _I : All inputs and I/O ports		
Operating free-air temperature range, TA:	SN74ALS641A, SN74ALS642A	0°C to 70°C
Storage temperature range		65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN74ALS641A SN74ALS642A		UNIT	
		MIN	NOM	MAX	
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
Vон	High-level output voltage			5.5	V
la.	Laurelaurelaurent aumant			24	mA
lOL	Low-level output current			48‡	IIIA
TA	Operating free-air temperature	0		70	°C

[‡] Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V



SDAS300 - MARCH 1995

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS			SN74ALS641A SN74ALS642A		
				MIN	TYP [†]	MAX	
٧IK		$V_{CC} = 4.5 \text{ V},$	$I_1 = -18 \text{ mA}$			-1.5	V
IOH		$V_{CC} = 4.5 \text{ V},$	V _{OH} = 5.5 V			0.1	mA
			I _{OL} = 12 mA		0.25	0.4	
VOL		$V_{CC} = 4.5 V$	I _{OL} = 24 mA		0.35	0.5	V
			$I_{OL} = 48 \text{ mA}^{\ddagger}$		0.35	0.5	
II	Control inputs	$V_{CC} = 5.5 V$,	V _I = 7 V			0.1	mA
1	Control inputs	V 55V	V. 27V			20	
ΉН	A or B ports§	$V_{CC} = 5.5 V,$	$V_1 = 2.7 \text{ V}$			20	μΑ
1	Control inputs	V 55V	V ₂ 0.4.V			-0.1	A
IIL	A or B ports§	$V_{CC} = 5.5 V$	V _I = 0.4 V			-0.1	mA
	SN74ALS641A	V 55V	Outputs high		25	37	
		Outputs low		33	47	^	
ICC	ONIZ444 00404	V 55V	Outputs high		8	15	mA
	SN74ALS642A	V _{CC} = 5.5 V	Outputs low		18	28	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L R _L	= 50 pF = 680 Ω = MIN t			UNIT
			MIN	MAX	MIN	MAX	
t _{PLH}	A or B		5	25	10	30	
^t PHL		B or A	3	18	5	22	ns
t _{PLH}	ŌĒ		8	30	10	30	
^t PHL		A or B	8	30	15	38	ns
t _{PLH}	DIR	A or B	8	32	10	30	ne
^t PHL		AUIB	8	32	15	38	ns

[¶] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

 $[\]ddagger$ Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V \$ For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

SN74ALS641A, SN74ALS642A, SN74AS641 OCTAL BUS TRANSCEIVERS WITH OPEN-COLLECTOR OUTPUTS

SDAS300 - MARCH 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I : All inputs and I/O ports	7 V
Operating free-air temperature range, T _A : SN74AS641	0°C to 70°C
Storage temperature range	-65°C to 150°C

recommended operating conditions

		SN74AS641			UNIT
		MIN	NOM	MAX	UNIT
Vсс	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
Vон	High-level output voltage			5.5	V
loL	Low-level output current			64	mA
TA	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SI	SN74AS641		
		TEST CO	TEST CONDITIONS		TYP‡	MAX	UNIT
VIK		V _{CC} = 4.5 V,	I _I = –18 mA			-1.2	V
Іон		V _{CC} = 4.5 V,	V _{OH} = 5.5 V			0.1	mA
VOL		V _{CC} = 4.5 V,	I _{OL} = 64 mA		0.35	0.55	V
	Control inputs	\\\ F \\	V _I = 7 V			0.1	mA
l _l	A or B ports	V _{CC} = 5.5 V	V _I = 5.5 V			0.1] ""
l	Control inputs	Van EEV	V. 27V			20	
lιΗ	A or B ports§	V _{CC} = 5.5 V,	V _I = 2.7 V			70 µ	μΑ
l	Control inputs	V	V ₁ = 0.4 V			-0.5	mA
ΙΙL	A or B ports§	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V			-0.75	IIIA
loo		V00 - 5 5 V	Outputs high		50	82	mA
ICC		V _{CC} = 5.5 V	Outputs low		84	136	IIIA

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

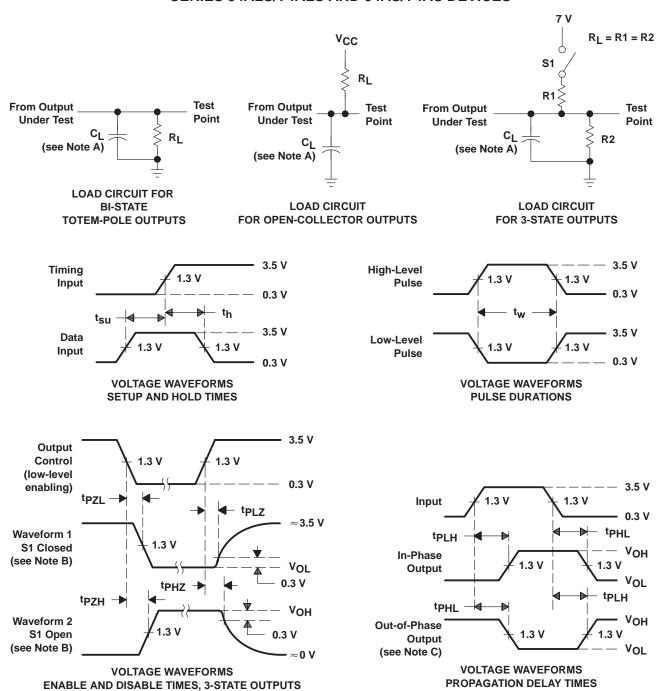
 $[\]mbox{\$ For I/O}$ ports, the parameters $\mbox{I}_{\mbox{\scriptsize IH}}$ and $\mbox{I}_{\mbox{\scriptsize IL}}$ include the off-state output current.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$\begin{tabular}{lll} $V_{CC}=4.5$ V to 5.5$ V, \\ $C_L=50$ pF, \\ $R_L=680$ $\Omega,$ \\ $T_A=MIN$ to MAX† \\ \hline &SN74AS641 \\ \hline &MIN&MAX \\ \end{tabular}$		UNIT
t _{PLH}	A or B	5 .	5	21	
t _{PHL}		B or A	1	7.5	ns
^t PLH		A B	5	21	
t _{PHL}	ŌĒ	A or B	1	9	ns
^t PLH	DIR	A or B	5	22	ns
^t PHL		AUID	1	10	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
 - D. All input pulses have the following characteristics: $PRR \le 1$ MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.
 - E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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